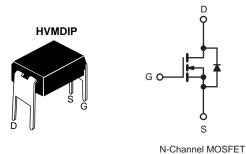


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	100				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.54			
Q _g (Max.) (nC)	8.3				
Q _{gs} (nC)	2.3				
Q _{gd} (nC)	3.8				
Configuration	Single				



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- 175 °C Operating Temperature
- Fast Switching and Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION				
Package	HVMDIP			
Lead (Pb)-free	IRFD110PbF			
Leau (Fb)-liee	SiHFD110-E3			
SnPb	IRFD110			
JIII	SiHFD110			

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage			V_{DS}	100	V		
Gate-Source Voltage			V_{GS}	± 20	V		
Continuous Drain Current	V _{GS} at 10 V	T _A = 25 °C		1.0	А		
	VGS at 10 V	T _A = 100 °C	I _D	0.71			
Pulsed Drain Current ^a			I _{DM}	8.0			
Linear Derating Factor				0.0083	W/°C		
Single Pulse Avalanche Energy ^b			E _{AS}	140	mJ		
Repetitive Avalanche Current ^a			I _{AR}	1.0	Α		
Repetitive Avalanche Energy ^a			E _{AR}	0.13	mJ		
Maximum Power Dissipation	Dissipation $T_A = 25 ^{\circ}\text{C}$		P _D	1.3	W		
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns		
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	00		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	°C		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 52 mH, R_g = 25 Ω , I_{AS} = 2.0 A (see fig. 12).
- c. $I_{SD} \le 5.6$ A, $dI/dt \le 75$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFD110, SiHFD110

Vishay Siliconix



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R_{thJA}	-	120	°C/W		

SPECIFICATIONS (T _J = 25 $^{\circ}$ C, u	nless otherw	vise noted)					
PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.12	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zoro Cata Valtaga Prain Current	I _{DSS}	V _{DS} =	V _{DS} = 100 V, V _{GS} = 0 V		-	25	
Zero Gate Voltage Drain Current		V _{DS} = 80 V	, V _{GS} = 0 V, T _J = 150 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 0.60 A ^b	-	-	0.54	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	50 V, I _D = 0.60 A ^b	0.80	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V 0.V		-	180	-	
Output Capacitance	Coss]	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		81	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.			15	-	
Total Gate Charge	Qg			-	-	8.3	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 5.6 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 ^b		-	2.3	
Gate-Drain Charge	Q _{gd}]	goo ng. o ana ro	-	-	3.8	
Turn-On Delay Time	t _{d(on)}			-	6.9	-	
Rise Time	t _r	V_{DD} = 50 V, I_{D} = 5.6 A, R_{g} = 24 Ω , R_{D} = 8.4 Ω , see fig. 10 ^b		-	16	-	ns
Turn-Off Delay Time	t _{d(off)}			-	15	-	
Fall Time	t _f			-	9.4	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	-11
Internal Source Inductance	L _S			-	6.0	-	- nH
Drain-Source Body Diode Characteristic	s			•		•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1.0	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	8.0	
Body Diode Voltage	V _{SD}	$T_J = 25$ °C, $I_S = 1.0$ A, $V_{GS} = 0$ V ^b		-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 5.6 A, dI/dt = 100 A/μs ^b		-	100	200	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.44	0.88	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

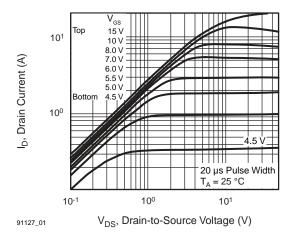


Fig. 1 - Typical Output Characteristics, T_A = 25 °C

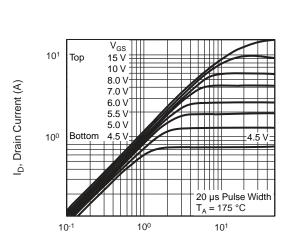


Fig. 2 - Typical Output Characteristics, T_A = 175 °C

V_{DS}, Drain-to-Source Voltage (V)

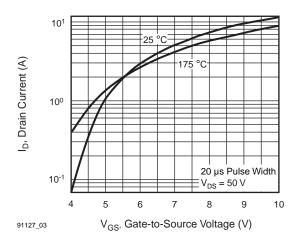


Fig. 3 - Typical Transfer Characteristics

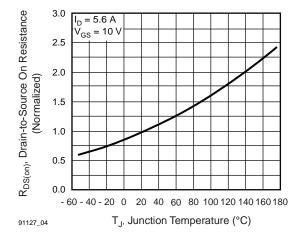


Fig. 4 - Normalized On-Resistance vs. Temperature

91127_02



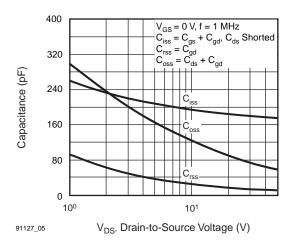


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

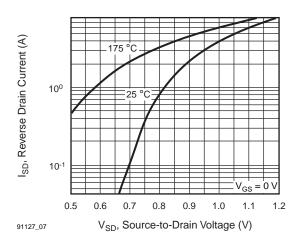


Fig. 7 - Typical Source-Drain Diode Forward Voltage

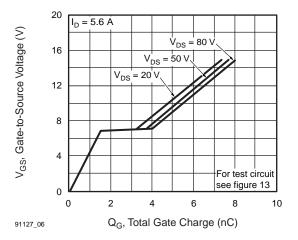


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

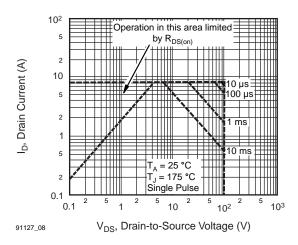


Fig. 8 - Maximum Safe Operating Area





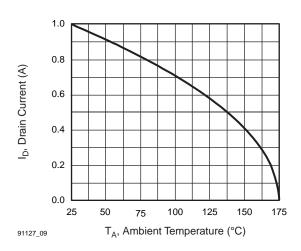


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

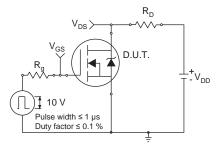


Fig. 10a - Switching Time Test Circuit

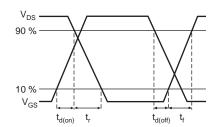


Fig. 10b - Switching Time Waveforms

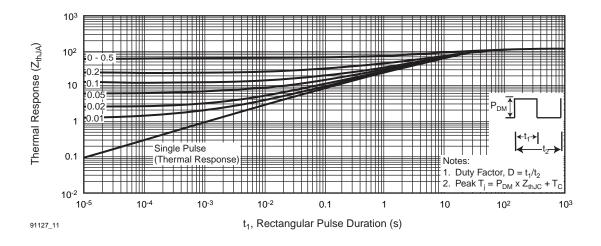


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



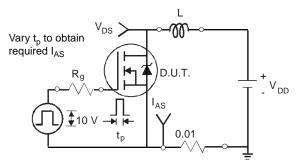


Fig. 12a - Unclamped Inductive Test Circuit

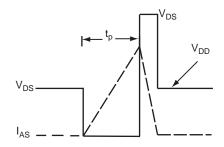


Fig. 12b - Unclamped Inductive Waveforms

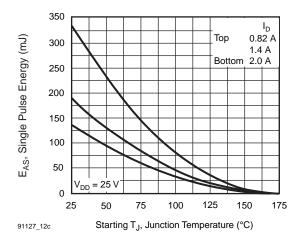


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

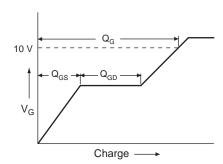


Fig. 13a - Basic Gate Charge Waveform

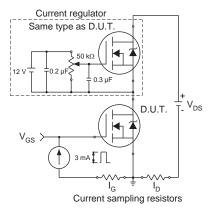
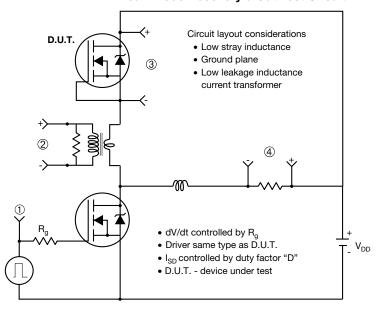


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit



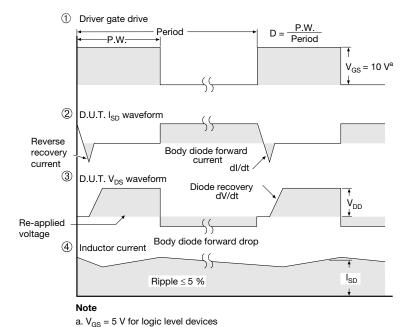
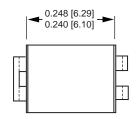
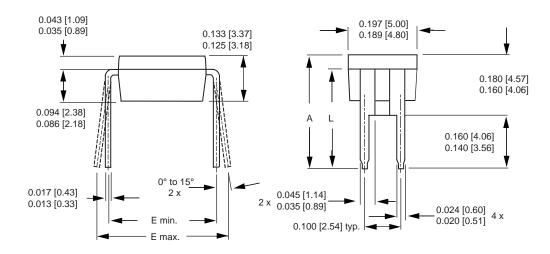


Fig. 14 - For N-Channel

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HVM DIP (High voltage)





	INCHES		MILLIMETERS		
DIM.	MIN.	MAX.	MIN.	MAX.	
A	0.310	0.330	7.87	8.38	
Е	0.300	0.425	7.62	10.79	
L	0.270	0.290	6.86	7.36	

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.

Document Number: 91361 Revision: 06-Sep-10



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